



Inverted vs standard PTB7:PC70BM organic photovoltaic devices. The benefit of highly selective and extracting contacts in device performance

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ABSTRACT

In this work we compare the photovoltaic performance of different cell designs, standard and inverted, for one of the most promising systems to achieve power conversion efficiencies over 10% in polymer:fullerene single cells, namely PTB7:PC70BM. Impedance spectroscopy, charge extraction and transient photovoltage are used in order to assign the electrical losses initially observed in the current density–voltage curve and understand the main limitation of every design. While inverted devices show competitive performance in terms of charge generation, transport of carriers and also for charge collection at electrodes, standard devices present additional resistive losses that are assigned to charge transfer issues at the active layer/anode interface. This additional resistance increase the overall series resistance of devices, lowers the fill factor and it is the ultimate responsible for the observed reduced device performance of standard cells in comparison to inverted ones. In this way, devices over 7.2% are reported with ZnO and MoO₃ as interlayer electrodes that act as improved highly selective and extracting contacts in comparison to standard PEDOT:PSS and Ca/Ag. Contacts are thus electrically optimized. Additional improvement of device performance must consider enhancement of intrinsic recombination properties of the blend. Lower molecular weights and/or any residual catalyst impurities with respect to other batches are the only limitation to reach record efficiencies as those shown in recent works.

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1. Introduction

The chemical design of novel donors for polymer based organic solar cell has been, without a shadow of a doubt, the step change in the process toward achieving sufficiently

high and appealing power conversion efficiencies (PCE) as to convert organic materials in a real alternative to compete in the photovoltaic market. Materials that combine low band-gap light absorption, adequate energy level positions and reasonable high carrier mobilities are considered to be the Holy Grail to move this technology one step further toward commercialization. A very recent example of active material development is a benzodithiophene derivative known as PTB7 from which devices up to 9.2% efficient are

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successfully processed [1]. However, this is also a good example to illustrate that improving the efficiency of a solar cell is not only a matter of the active material. Non-photoactive layers such as electrode interlayers and/or optical spacers also play a crucial role in the overall efficiency. In this way, initially reported 7.4% [2] efficient PTB7 based devices yielded 8.37% [3] and 8.1% [4], when either a polyfluorene derivative – PFN – or bathocuproine (BCP) was respectively used as cathode interlayer. Last but not least, alternative cell designs can also contribute to further enhance the light to electricity conversion [5,6]. In this regard, inverted device structures can take advantage of the vertical phase separation and concentration gradient in the active layer and offer superior contact selectivity with the potential to show surprisingly large fill factors (FF) and better long-term ambient stability [7]. This was the approach used by He et al. to report a drastic boost in PCE of PTB7 based devices and take it to 9.2% [1]. It is, however, important to note that all the efficiencies mentioned above are record efficiencies achieved with not always commercially available small batches of active material obtained under a very precise control of the synthesis route and conditions, especially in terms of molecular weight and impurities. When the synthesis is scaled up, those efficiencies are difficult to reproduce at different labs and average values are considerably lower.

More insight on all the internal mechanisms involved in the photovoltaic conversion of standard and inverted cells is therefore needed in order to first understand these batch to batch variations and second to clearly assign the benefits of inverted structures to concrete facts. There are several techniques that can provide valuable information on electrical parameters in operating devices. Charge extraction (CE) informs on the charge distribution within the bulk at different applied bias and the number of charges that the system is capable of accumulating and extracting. Additionally, transient photovoltage (TPV) experiments provide information on the carrier recombination dynamics and carrier lifetime dependency on voltage [8,9]. In addition to photo-induced charge transfer measurements, impedance spectroscopy (IS) is useful to study all resistive and capacitive processes taking place in operating device

such as recombination, transport mechanisms, and charge accumulation [10].

In a previous study [11], we demonstrate that transport of carriers and contact selectivity are both limiting factors for the PTB7:fullerene system. We proved that the overall device efficiency is a balance between the recombination kinetics in the bulk of the active layer, undesired resistance to transport of carriers and leakage current due to low selectivity of the contacts. We also gave recommendations on how to solve these issues: higher proportions of fullerene can be used to reach selective contacts, and the use of additives improves charge generation and extraction and removes any issue related to transport of carriers.

In this paper, we have followed these recommendations to improve the contact selectivity and hence to routinely fabricate devices with different commercially available batches of PTB7 over 7.2%. We analyze their response in either standard or inverted configuration using all techniques aforementioned in order to identify their limitations. IS results reveal that both contact selectivity and morphology of inverted devices are fully optimized and no issues related to either transport of carriers in the active layer or charge extraction at the electrodes are observed. Any efficiency enhancement for this system has therefore to arise from optical improvements. Standard configurations show however an additional resistance that can be assigned to charge transfer issues from the active layer to the anode. This lack of an efficient extracting electric contact is the responsible for the reduced device performance.

2. Photovoltaic characterization (JV and EQE): identifying losses

The current density–voltage (J – V) curves for devices fabricated with the configuration ITO/PEDOT:PSS/Active layer/Ca/Ag (standard) and ITO/ZnO/Active layer/MoO₃/Ag are shown in Fig. 1 along with the External Quantum Efficiency (EQE) and the absorption. The figure of merits for both devices is also listed in Table 1.

The EQE follows the absorption in the visible part of the spectrum, while they show an anti-symbatic behavior in the UV. This indicates that photons in the UV hardly

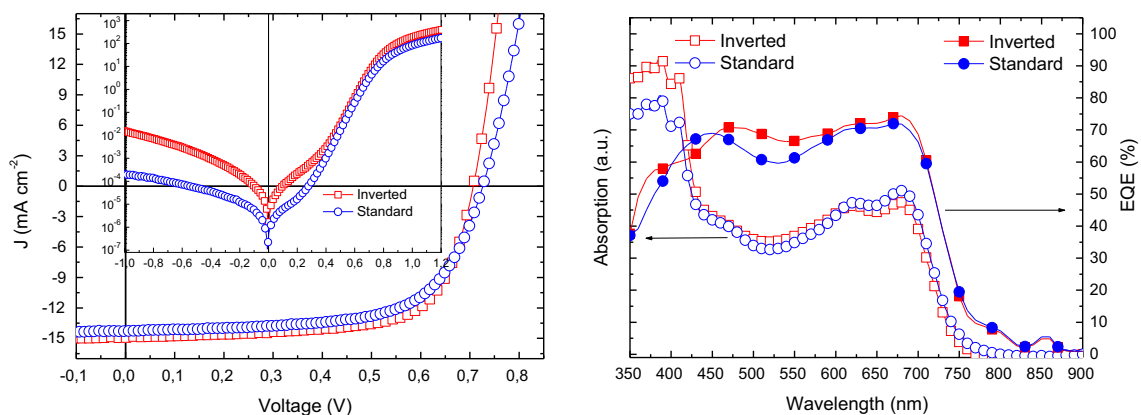


Fig. 1. (Left) J – V curve for the standard device design ITO/PEDOT:PSS/PTB7:PC70BM/Ca/Ag (squares) and inverted ITO/ZnO/PTB7:PC70BM/MoO₃/Ag (circles). Inset: dark J – V curves for the same devices in a log–log scale. (Right) absorption (open symbols) and External Quantum Efficiencies (filled symbols) for the same devices.

Table 1

Figure of merits for standard and inverted devices whose J - V curves are shown in Fig. 1.

Cell design	V_{oc} (V)	J_{sc} (mA cm^{-2})	FF	PCE (%)
Standard	0.72	14.28	0.65	6.7
Inverted	0.70	14.93	0.69	7.2

contribute to the measured J_{sc} . EQE over 70% implies that the device development is such that the internal quantum efficiency (IQE) is already over 90%, as previously measured [2]. This practically means that all that is absorbed is efficiently converted into current. Furthermore, the light absorption of the inverted film in the UV part is considerably higher than that for the standard device, most likely due to the absorption of the ZnO film, while they absorb approximately the same within the visible part. This evidences the capability of inverted devices to provide a better control of photon harvesting from the Sun's spectrum. The EQE is in good agreement with the J_{sc} obtained from the J - V curves for both devices. The integration over the spectrum of the EQE and the incident photon flux under AM1.5 solar irradiance is calculated to be 14.93 and 15.54 mA cm^{-2} for standard and inverted devices, respectively.

The inverted device shows a better efficiency at 1 Sun primarily due to the larger photocurrent and improved FF. The larger photocurrent might be a direct consequence of the better absorbance around 500 nm, although morphology issues cannot be still ruled out. The enhanced FF can be in principle assigned to a lower series resistance, but the origin of this increased R_{series} for the standard device cannot be ascertained only from this set of data. Furthermore, the leakage current at -1 V is two orders of magnitude higher for the inverted devices, but it cannot be the main responsible for the different performance observed, as otherwise, inverted devices should show lower PCE than standard configurations. Further experiments are thus necessary in order to shed light on all these issues. IS under dark and under illumination, CE and TPV were carried out with the objective of clarifying where losses arise from in standard cells in comparison to inverted ones.

3. Assignment of losses

3.1. Capacitance–voltage measurements in the dark: selectivity of contacts and leakage current

The proportion of the cathode that is covered by fullerene can be measured in completed devices by using capacitance–voltage (C - V) measurements in the dark [12]. These calculations gave nearly full coverage of 93% for inverted devices and a reasonably good coverage for the standard devices of 80% (Fig. S1). Both values are expected to be in agreement with a highly selective contact. However, these results imply that there is indeed a change in the bulk morphology when the polarity of the device is inverted. In standard devices, there is a material concentration gradient that increases the fullerene proportion toward the top electrode (Ca/Ag that acts as a cathode), while in inverted configuration most of the fullerene tends to be

close to the bottom electrode (ZnO/ITO that acts now as a cathode), with a gradient of fullerene concentration that decreases toward the top electrode. Different morphologies depending upon the starting substrate on top of which the same photoactive film is deposited are not unusual for polymer:fullerene solar cells since specific interactions between the organic materials and the substrate, due to mainly different surface energy and/or hydrophobicity, have been demonstrated to have a strong effect on morphology [5]. Therefore, inverted devices benefit from a more favorable vertical segregation. The origin of the increased leakage current observed for the inverted device may then be related to the active layer/anode interface which is not accessible from CV measurements. In any case, it is clear that the leakage current is not the responsible for the reduced device performance and there must be additional losses taking place in the standard configuration. In the following section, this issue will be clarified by studying the device response under illumination.

3.2. Impedance spectroscopy under 1 Sun: resistive and capacitive processes

Impedance spectroscopy under illumination for inverted devices show mainly one arc in the Nyquist plot (Fig. 2 Up). However, at high voltages, the standard device shows another arc composed of a small additional resistance and a capacitance. The presence of this additional arc is best observed in the capacitance–frequency spectra (Fig. 2 Down). The inverted device shows only one plateau in the range of frequencies between 100 and 1×10^5 Hz, indicating that only one capacitance dominates the device. On the contrary, the standard configuration device shows two capacitances in the form of two plateaus.

Impedance spectra can be fitted to two different equivalent circuits depending on the cell design (Fig. S2). The inverted configuration can be modeled by a simple circuit with a recombination resistance (R_{rec}) and the chemical capacitance (C_{μ}) along with the series resistance due to contact and wires (R_s). The standard configuration needs an additional RC subcircuit connected in series with a resistance, R_{hf} , and a capacitance C_{hf} in parallel.

Regarding resistive processes and electrical losses in the bulk material, the low frequency response at high applied bias is connected to the recombination kinetics of the system. Alternatively, in the low applied bias region, the IS response is likely dominated by the shunt resistance. Furthermore, the high frequency response has been previously ascribed to issues related to transport of carriers in the bulk of the active layer, although it can also be related to external interfaces for morphologically optimized devices with considerably large EQE and very thin active films for which transport properties do not limit the performance of the cell. In any case, it possesses a total current loss for the device performance [13].

With respect to charge storage and carrier extraction, the device capacitance observed at low frequencies of the IS spectra for systems not severely affected by transport losses, is governed by the chemical capacitance due to excess carriers, C_{μ} [14,15]. This is related to the change in the occupancy by electrons of the fullerene LUMO. At low

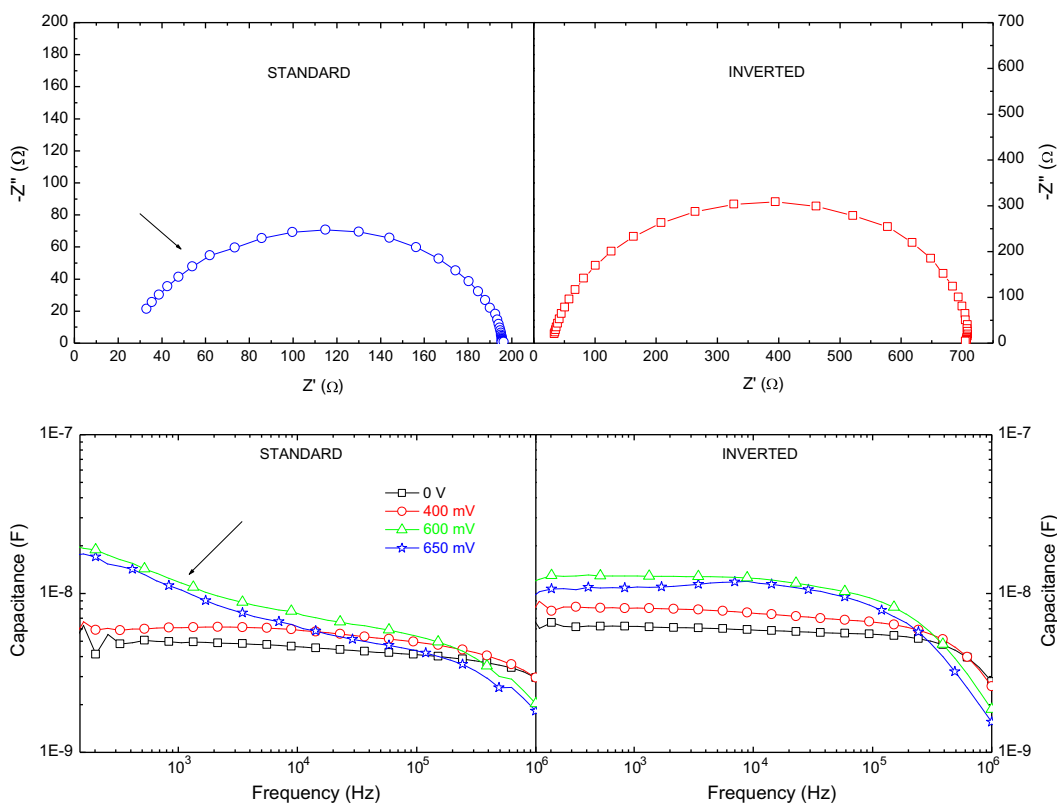


Fig. 2. (Up) IS response for standard (left) and inverted (right) devices measured under 1 Sun and at applied bias of 0.55 V. (Down) capacitance-frequency spectra for standard (left) and inverted (right) devices measured under 1 Sun at selected DC applied bias. The arrow indicates the effect of the additional resistance found for standard devices.

applied bias the capacitive response is dominated by the dielectric properties of the active layer. As we increase the applied bias, the density-of-states (DOS) of the acceptor LUMO levels starts being filled by electrons, and charge is stored with the consequent increase in C_{μ} .

3.3. Fitting results for IS at 1 Sun: Additional resistive losses limit device performance

Fig. 3 shows the fitting results. Interestingly, C_{μ} observed for standard and inverted devices perfectly overlap (Fig. 3 up left). An exponential increase over nearly two orders of magnitude is expected at forward bias as the DOS occupancy takes places. Furthermore, in spite of different vertical segregation profiles, recombination resistances are very similar for both devices. The shunt resistance for the standard device is slightly higher, fully consistent with the lower leakage current observed in dark conditions.

Finally, the additional resistance observed for high frequencies for the standard configuration is rather small (below 10Ω). However, since this is the only distinctive issue, it might well be the responsible for the reduced device performance. The origin of this additional resistance can only be related to either (i) limited transport properties through the PEDOT:PSS layer or (ii) charge transfer issues between the active layer and the anode that can lead to an increased overall series resistance.

3.4. Origin of additional resistive losses: Interlayer conductivity or interface issue

In order to discern which of those is more relevant, identical standard devices were made with PEDOT:PSS layers of different conductivities, ranging from the high resistivity of the Al4083 dispersion ($500\text{--}5000 \Omega \text{ cm}$) to the highly conductive PH500 (300 S cm^{-1}). All devices showed very similar PCE and FF (Fig. S3). Furthermore, the additional arc composed of a small resistance and the capacitance is also present for all these devices in the IS spectra (not shown). Thus, we can definitely rule out the conductivity of the interlayer as the origin for this additional resistance.

This additional resistance at high frequencies can be related to the external interfaces for morphologically optimized devices with very thin active films for which transport properties do not limit the performance of the cell. As a consequence, obtained EQEs are relatively high at short circuit conditions. In any case, this additional resistance at the active film/anode interface needs to be included into the overall series resistance and added to the one referring to contacts and wires (calculated from the intercept of the high frequency arc with the x -axis and the zero value in the Nyquist plot, Fig. S4). It, therefore, explains the larger R_{series} measured by IS for the standard cell in comparison to the inverted one (Fig. S4).

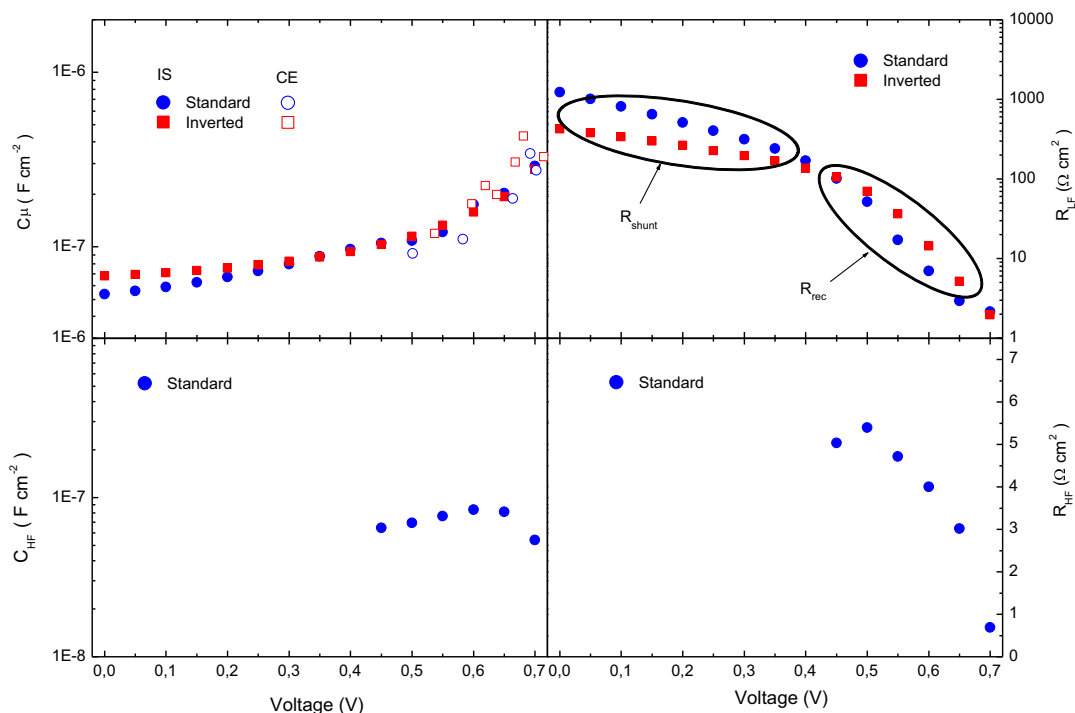


Fig. 3. Fitting results, resistance (right) and capacitive (left) data, for IS measurements performed at 1 Sun light intensity for standard (circles) and inverted (squares) using the equivalent circuits given in Fig. S12. The chemical capacitance (up left) calculated from CE measurements under equivalent conditions (open circles) is in good agreement with IS data (filled symbols).

3.5. Transient photovoltage measurements: bulk recombination processes

Two techniques are most widely used to understand recombination kinetics in working OPVs, TPV and IS. Recombination processes studied by IS under constant illumination gave very similar recombination resistance for inverted and standard cells. In TPV, the device is held at open circuit conditions. It is important to realize that at V_{oc} conditions, the net current flowing through the device is zero and the effect of the series resistance is null. IS under constant illumination, in contrast, does not operate at open circuit conditions, thus the effect of the series resistance will indeed be taken into account. This basically means that the recombination processes studied by the two techniques can be substantially different. Furthermore, the time window for monitoring the transients in TPV is restricted to the resolution of the detection system (in our system limited to μs). Although this is normally sufficiently fast to study in detail non-geminate recombination in working OPVs, which define to a large extent, the current density curve under illumination, it is not useful to characterize faster recombination processes independently on their origin.

Fig. 4 Left shows the charge density as a function of the applied light bias for standard and inverted devices measured by CE in the region from 550 to 750 mV. The density of charges for this region refers to the excess of charges that accumulate within the bulk of the device.

The linear part below 0.55 V is not of interest since it is dominated by the dielectric properties of the active layer. The fact that the density of charges grows exponentially with the applied bias suggests that there is a splitting of the quasi-Fermi levels after this threshold for both devices. In addition, it is within the same order of magnitude for both devices, with a slightly larger density of charges accumulated in the bulk of inverted devices. The recombination dynamics for a small perturbation at 470 nm for both devices measured by TPV and correlated with the density of charges obtained from CE are shown in Fig. 4 right. As it can be observed, recombination times for charge densities under 1 Sun ($4 \times 10^{16} \text{ e}^-/\text{cm}^3$) are close to 1 μs . Both are within the same order of magnitude with small differences most likely due to experimental errors rather than to different recombination mechanisms taking place in the bulk of the device. More importantly, the power law, λ , that relates the charge density with the small perturbation charge carrier lifetime [16] (i.e. the slope in Fig. 4 right) gives very similar values for standard and inverted devices of 1.68 and 1.93 respectively. These very similar empirical reaction orders must imply also very similar bimolecular recombination processes under 1 Sun illumination, mainly governed by non-geminate bulk recombination, and excluding thus any other faster recombination process. These similar kinetics are also in agreement with the RC constants measured by IS under illumination at 0.7 V, namely 2.3 and 1.8 μs for inverted and standard devices, respectively.

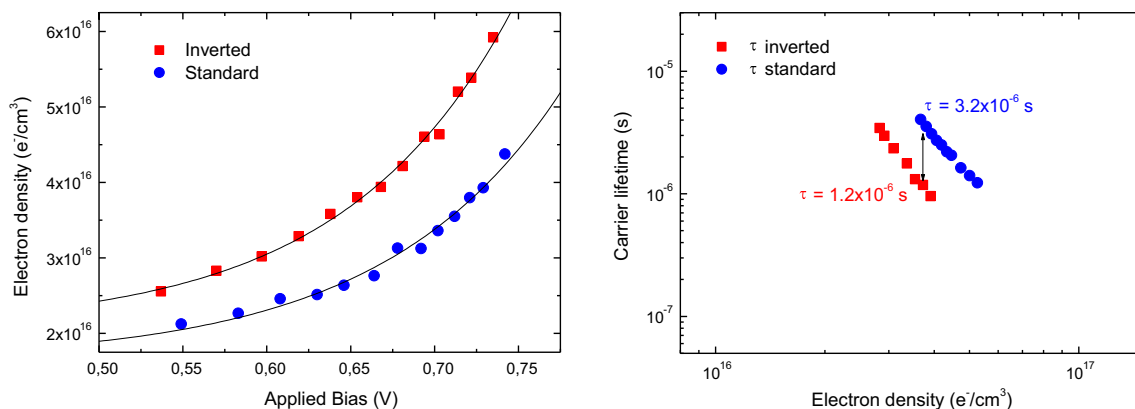


Fig. 4. (Left) Carrier density values as a function of the applied bias extracted from CE measurements for standard (circles) and inverted (squares) devices. The fitting of the experimental data to a first order exponential is also shown (solid lines). (Right) charge carrier lifetimes at different carrier densities.

3.6. Summary: final assignment of extra resistive losses for standard devices

In summary, we have used IS, CE and TPV to analyze in detail all the working mechanisms taking place in standard and inverted PTB7:PC70BM devices immediately after light excitation. Thanks to this detailed study we are able to identify the main limitations in device performance. Inverted devices with ZnO and MoO₃ as bottom and top contact respectively present improved conditions in terms of contact selectivity and charge extraction at the electrodes. Standard devices with PEDOT:PSS and Ca/Ag as an anode and cathode respectively, show an additional resistance at the PEDOT:PSS/active layer that increases the overall series resistance and negatively affects the FF, and hence the PCE.

Standard and inverted devices also show different vertical segregation profiles with superior cathode selectivity for the inverted design thanks to improved fullerene coverage. The larger leakage currents measured in the dark might however be the result of the anode contribution, but do not affect device performance under illumination. Recombination processes are also very similar with no substantial differences that can explain the observed variations in the conversion efficiency. A tiny increase in the light absorption around 500 nm for the inverted device, and principally the increase in R_{series} that leads to a more difficult charge extraction for the standard device, explain the slightly larger photocurrent and FF measured for the inverted device. This is in agreement with what has been recently observed for other polymer based systems [17], pointing to the fact that inverted designs are in general more appropriated for polymer:fullerene solar cells. All in all, the inverted device is fully electrically optimized and therefore any performance improvement for this particular commercial batch can only arise from optical improvements. Lower molecular weights and/or any residual catalyst impurities with respect to other batches are the only limitation to reach record efficiencies as those shown in recent papers.

4. Experimental section

4.1. Materials

The following materials were used as received PTB7 (1-material), PC₇₀BM (SES Corporation), PEDOT:PSS (Al 4083, PH and PH500 from Heraus Precious Materials), chlorobenzene (Scharlau). Blends of donor:acceptor were prepared prior to device fabrication. PTB7 (10 mg) and PC₇₀BM (15 mg) were initially dissolved in chlorobenzene inside a nitrogen glove-box (970 μ l). This solution was left stirring overnight at 60 °C. After 24 h, 30 μ l of diiodooctane (DIO) was added. The new solution was stirred 1 h at 70 °C just before deposition.

4.2. Device preparation

Standard devices were fabricated in the configuration ITO/PEDOT:PSS/Active layer/Ca/Ag. Structured indium tin oxide (ITO) coated glass substrates were cleaned in subsequent acetone and isopropyl alcohol ultrasonic baths followed by 5 min of UV ozone treatment. A thin layer of PEDOT:PSS (dispersions with different conductivities - namely Al4083, PH, and PH500- were equally used) was spin coated on the substrates to smooth the ITO surface and to act as the hole selective contact. Substrates were annealed at 120 °C for 10 minutes in air. The PTB7:PC₇₀BM film was spin-coated in nitrogen at 1200 rpm (90 nm). Finally, the cathode was thermally evaporated (10 nm Ca and 100 nm of Ag) at a base pressure of 4×10^{-6} mbar to define an OPV active area of 9 mm². Devices were encapsulated with an epoxy resin (LP655 DELO KATIOBOND) and a glass cover and were characterized outside the glove-box.

Inverted devices were fabricated in the configuration ITO/ZnO/Active layer/MoO₃/Ag onto the same ITO starting substrates. A colloidal suspension of ZnO was prepared as reported by White et al. [18]. This suspension was spin coated onto pre-cleaned ITO substrates at 4000 rpm. The resulting film was annealed at 150 °C for 5 min. The PTB7:PC₇₀BM film was spin-coated as in the previous case.

Finally, 3 nm of MoO₃ and 100 nm of Ag were thermally evaporated in order to finish the device. Devices were encapsulated as before.

4.3. Device characterization

Current density–voltage (*J*–*V*) characterization was performed with a Keithley 2420 Source–Measure Unit under 100 mW cm^{−2} AM1.5G illumination. The calibration of the light intensity was carried out with a NREL certified monocrystalline silicon photodiode. Film thicknesses were measured by a Dektak 150 surface profilometer.

The charge extraction setup consist in a white light LED ring from LUXEON® Lumileds, these are focussed onto the devices that are held in open circuit equilibrium. Devices are connected to a DC power supply and a function generator TGP110. The light is switched off and the circuit is temporally closed, while charge are forced to pass through an oscilloscope TDS 2022 from Tektronix© that registers the drop in voltage across a resistance of 50 Ω.

In TPV measurements devices are connected to the 1 MΩ input terminal of an oscilloscope Tektronix© TDS2022 and the background illumination was obtained from a ring of 6 white LED's from LUXEON® The small perturbation (2 mV) was applied through a light pulse (N₂ laser nominal wavelength, 50 ns pulses). Polaron–recombination rate was calculated for illumination intensities ranging from 0.1 Sun to 1 Sun.

Impedance spectra were performed with Autolab PGSTAT-30 equipped with a frequency analyzer module. A small voltage perturbation (20 mV rms) is applied at frequencies from 1 MHz to 1 Hz. Measurements were carried out under 1 sun light intensity calibrated with a monocrystalline silicon photodiode sweeping the DC voltage in the range 0–*V*_{oc}. Recombination resistance, *R*_{rec}, and chemical capacitance, *C*_μ were directly extracted from the low-frequency region as previously reported [15].

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Appendix A. Supplementary material

Supplementary data associated with this article can be found, in the online version, at <http://dx.doi.org/10.1016/j.orgel.2014.08.008>.

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